

Search Notes

Application/Control No.

10/809,241

Examiner

Alvin C. Chin-Shue

Applicant(s)/Patent under
Reexamination

LABRASH, RICHARD

Art Unit

3634

SEARCHED

Class	Subclass	Date	Examiner
	<i>update</i>	<i>6-30-06</i>	<i>AS</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR